Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/814,781	TANNER, THOMAS
Examiner	Art Unit
Alan S. Chen	2182

	SEARCHED		
Class	Subclass	Date	Examiner
710	30	9/25/2006	ASC
	60		
1	62		
725	90		
	135		
	143	J	7

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT Inventor Search	9/25/2006	ASC
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